

Search Notes

Application/Control No.

10/630,019

Examiner

Nam V. Nguyen

Applicant(s)/Patent under
Reexamination

CHUEY, MARK D.

Art Unit

2635

SEARCHED

Class	Subclass	Date	Examiner
340	825.69	5/25/2005	NN
	825.75	5/25/2005	NN
	5.2	5/25/2005	NN
	5.2+	5/25/2005	NN
	5.7+	5/25/2005	NN
341	50	5/25/2005	NN
	176	5/25/2005	NN
348	734	5/25/2005	NN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search East: USPAT; US-PUBS; EPO; JPO and Derwent.	5/25/2005	NN